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<u>L13</u>	L10 and (id\$1 or identification\$1 or identify\$5) near5 register\$1 near15 (bit\$1 or position\$1) and transfer\$6 near6 (data or block\$1 or group\$1 or byte\$1 or word\$1 or portion\$1 or segment\$1 or bit\$1)	838	<u>L13</u>
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 Computer-Aided Design of Integrated Circuits and Systems, IEEE Transaction on , Volume: 7 , Issue: 1 , Jan. 1988
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 The Ninth International Symposium on High-Performance Computer Architect 2003. HPCA-9 2003. Proceedings. , 8-12 Feb. 2003
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Active Matrix Liquid Crystal Displays, 1995. AMLCDs '95., Second International Workshop on , 25-26 Sept. 1995

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Takei, T.; Sekine, M.; Nishi, H.; Kitahara, T.; Masuda, A.;

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7 Aliasing errors in signature analysis testing of integrated circuits

Damiani, M.; Olivo, P.; Favalli, M.; Ricco, B.;

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